

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination LIN, YU-CHIEH	
		Examiner Chia-Wei A. Chen	Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,859,609	02-2005	Watkins, Daniel	386/46
*	B	US-5,477,264	12-1995	Sarbadhikari et al.	348/231.6
*	C	US-2002/0023206	02-2002	Klein, Dean A.	713/1
*	D	US-5,016,107	05-1991	Sasson et al.	348/231.1
*	E	US-6,995,793	02-2006	Albadawi et al.	348/239
*	F	US-6,104,430	08-2000	Fukuoka, Hiroki	348/231.6
*	G	US-7,170,551	01-2007	Fichtner, Mark R.	348/207.1
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.